



N 沟道增强型场效应晶体管
N-CHANNEL MOSFET
FHL250N8F2A

主要参数 MAIN CHARACTERISTICS

ID (Silicon Limited)	300 A
VDSS	85 V
Rdson-typ (@Vgs=10V)	2.0 mΩ
Qg-typ	138.3 nC

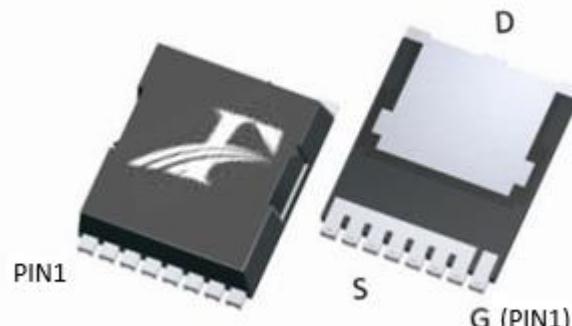
用途 APPLICATIONS

电池管理系统	Battery Management System
电动车控制器	Electric vehicle controller
高频开关电源	High efficiency switch mode power supplies
同步整流	Synchronous Rectification

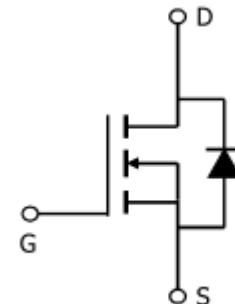
产品特性 FEATURES

低栅极电荷	Low gate charge
低 Crss (典型值 152 pF)	Low Crss (typical 152 pF)
开关速度快	Fast switching
100% 经过热阻测试	100% DVDS tested
100% 经过雪崩测试	100% avalanche tested
100% 经过 Rg 测试	100% Rg tested
符合 RoHS 标准	ROHS compliant
SGT 工艺	SGT technology

封装形式 Package



等效电路 Equivalent Circuit



绝对最大额定值 ABSOLUTE RATINGS ($T_c=25^\circ\text{C}$)

项目 Parameter	符号 Symbol	数值 Value	单位 Unit
		FHL250N8F2A	
最高漏极—源极直流电压 Drain-Source Voltage	V_{DS}	85	V
连续漏极电流* Drain Current -continuous *	$I_D(T_c=25^\circ\text{C}), \text{Silicon Limited}$	300	A
	$I_D(T_c=25^\circ\text{C}), \text{Package Limited}$	253	A
	$I_D(T_c=100^\circ\text{C}), \text{Silicon Limited}$	160	A
最大脉冲漏极电流 (注 1) Drain Current – pulse (note 1)	I_{DM}	1012	A
最高栅源电压 Gate-Source Voltage	V_{GS}	± 20	V
单脉冲雪崩能量 (注 2) Single Pulsed Avalanche Energy (note 2)	E_{AS}	450	mJ
雪崩电流 (注 1) Avalanche Current (note 1)	I_{AS}	30	A
二极管反向恢复最大电压变化速率 (注 3) Peak Diode Recovery dv/dt (note 3)	dv/dt	5.0	V/ns
耗散功率 Power Dissipation	$P_D(T_c=25^\circ\text{C})$	250	W
	-Derate above 25°C	2.0	W/ $^\circ\text{C}$
最高结温及存储温度 Operating and Storage Temperature Range	T_J, T_{STG}	150, -55 ~ +150	$^\circ\text{C}$
引线最高焊接温度 Maximum Lead Temperature for Soldering Purposes	T_L	260	$^\circ\text{C}$

*漏极电流由最高结温限制

*Drain current limited by maximum junction temperature

电特性 ELECTRICAL CHARACTERISTICS

项目 Parameter	符号 Symbol	测试条件 Tests conditions	最小 Min	典型 Typ	最大 Max	单位 Units	
关态特性 Off -Characteristics							
漏一源击穿电压 Drain-Source Voltage	BVDSS	ID=250μA, VGS=0V	85	95	-	V	
击穿电压温度特性 Breakdown Voltage Temperature Coefficient	ΔBVDSS/Δ TJ	ID=250μA, referenced to 25°C	-	0.09	-	V/°C	
零栅压下漏极漏电流 Zero Gate Voltage Drain Current	IDSS	VDS=85V, VGS=0V, TC=25°C	-	-	1	μA	
		VDS=68V, TC=125°C	-	-	100	μA	
栅极体漏电流 Gate-body leakage current	IGSS (F/R)	VDS=0V, VGS =±20V	-	-	±100	nA	
通态特性 On-Characteristics							
阈值电压 Gate Threshold Voltage	VGS(th)	VDS = VGS , ID=250μA	2.0	3.0	4.0	V	
静态导通电阻 Static Drain-Source On-Resistance	RDS(ON)	VGS =10V , ID=50A	-	2.0	2.7	mΩ	
动态特性 Dynamic Characteristics							
输入电容 Input capacitance	Ciss	VDS=42.5V, VGS =0V, f=1.0MHz	-	8237	-	pF	
输出电容 Output capacitance	Coss		-	1549	-		
反向传输电容 Reverse transfer capacitance	Crss		-	152	-		
开关特性 Switching Characteristics							
延迟时间 Turn-On delay time	td(on)	VDS=42.5V, RG=3Ω VGS =10V (note 4, 5)	-	32	-	ns	
上升时间 Turn-On rise time	tr		-	115	-	ns	
延迟时间 Turn-Off delay time	td(off)		-	93	-	ns	
下降时间 Turn-Off Fall time	tf		-	140	-	ns	
栅极电荷总量 Total Gate Charge	Qg	VDS =42.5V , ID=50A , VGS =10V (note 4, 5)	-	138.3	-	nC	
栅一源电荷 Gate-Source charge	Qgs		-	39.5	-	nC	
栅一漏电荷 Gate-Drain charge	Qgd		-	36.8	-	nC	
漏一源二极管特性及最大额定值 Drain-Source Diode Characteristics and Maximum Ratings							
正向最大连续电流 Maximum Continuous Drain -Source Diode Forward Current	Is		-	-	253	A	
正向最大脉冲电流 Maximum Pulsed Drain-Source Diode Forward Current	ISM		-	-	1012	A	
正向压降 Drain-Source Diode Forward Voltage	VSD	VGS=0V, Is=50A	-	-	1.2	V	
反向恢复时间 Reverse recovery time	trr	VGS=0V, Is=50A ,dI/dt=100A/μs (note 4)	-	80	-	ns	
反向恢复电荷 Reverse recovery charge	Qrr		-	196	-	nC	

热特性 THERMAL CHARACTERISTIC

项目 Parameter	符号 Symbol	FHL250N8F2A	单位 Unit
结到管壳的热阻 Thermal Resistance, Junction to Case	R _{th(j-c)}	0.5	°C/W
结到环境的热阻 Thermal Resistance, Junction to Ambient	R _{th(j-A)}	62.5	°C/W

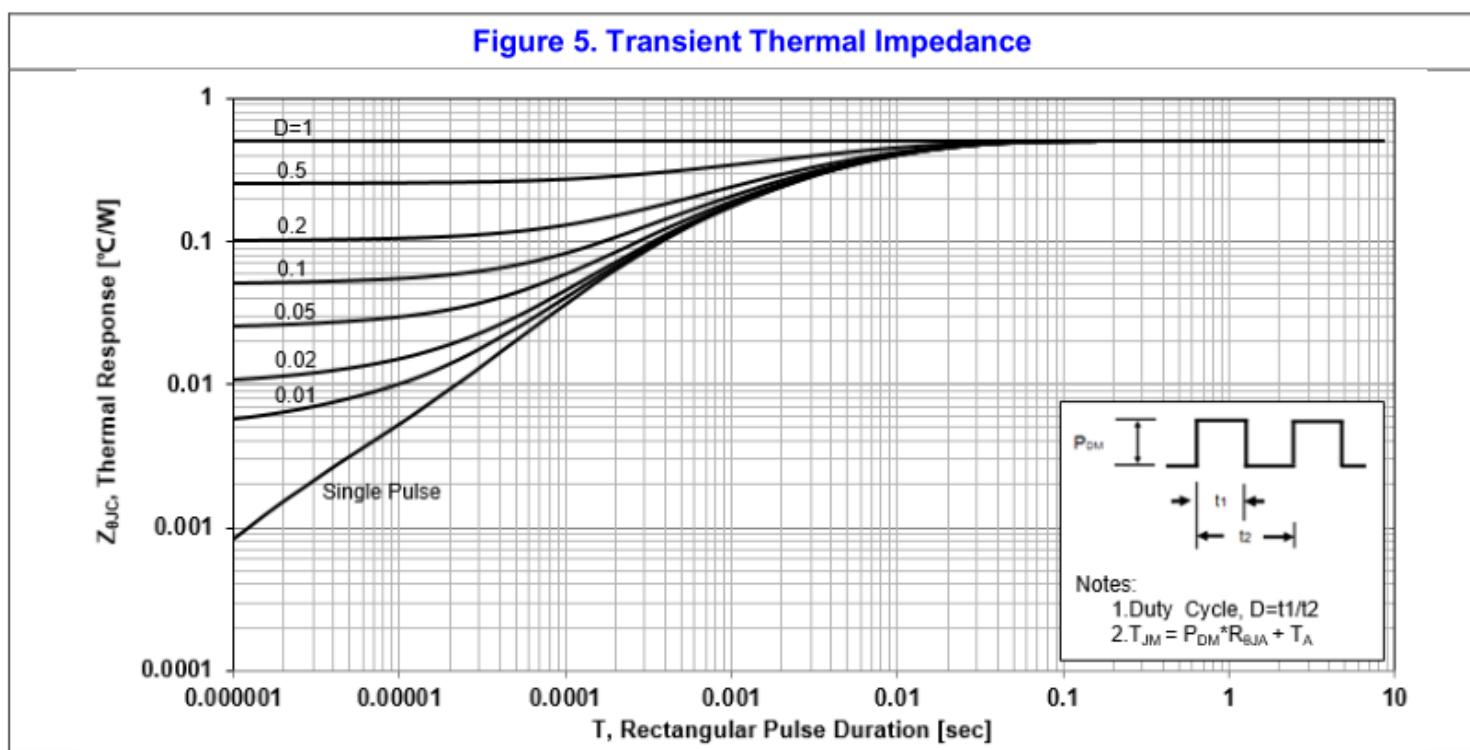
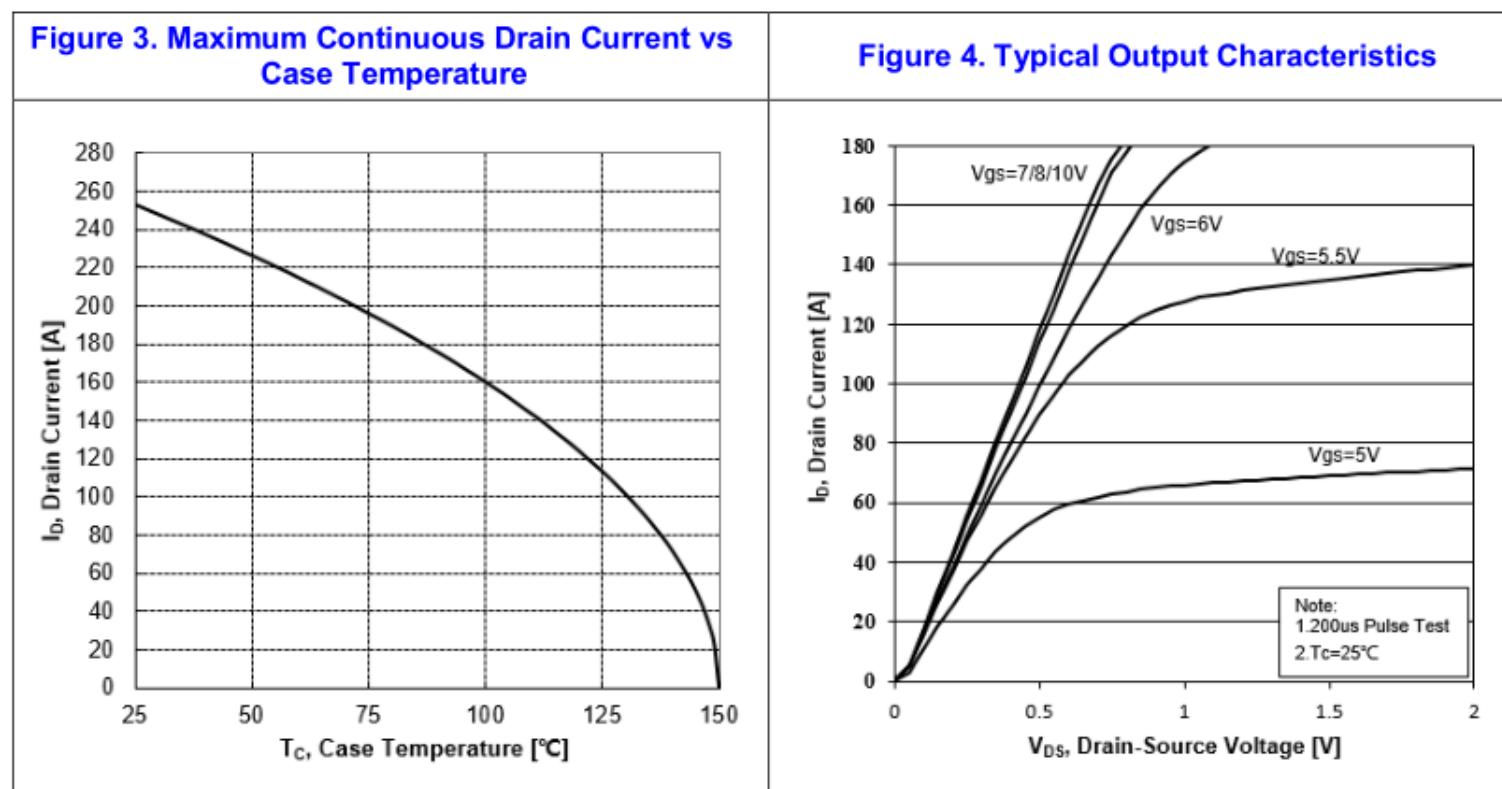
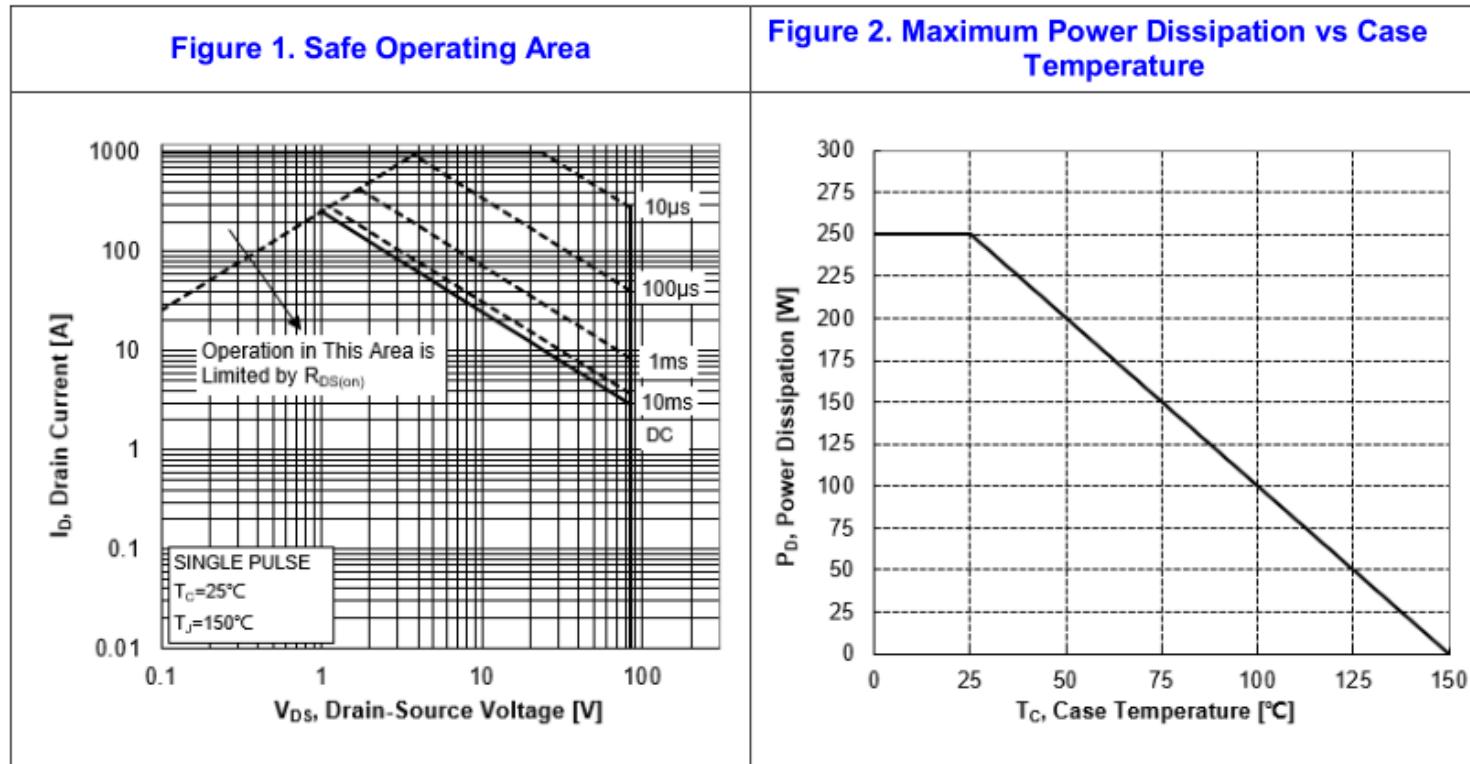
注释:

- 1: 脉冲宽度由最高结温限制
- 2: L=1mH, I_{AS}=30A, V_{DD}=50V, R_G=25 Ω,起始结温 T_J=25°C
- 3: I_{SD} ≤ 253A, di/dt ≤ 100A/μs, V_{DD}≤BV_{DSS},起始结温 T_J=25°C
- 4: 脉冲测试: 脉冲宽度 ≤300μs,占空比≤2%
- 5: 基本与工作温度无关

Notes:

- 1: Pulse width limited by maximum junction temperature
- 2: L=1mH, I_{AS}=30A, V_{DD}=50V, R_G=25 Ω, Starting T_J=25°C
- 3: I_{SD} ≤ 253A, di/dt ≤ 100A/μs, V_{DD}≤BV_{DSS}, Starting T_J=25°C
- 4: Pulse Test: Pulse Width ≤300μs, Duty Cycle≤2%
- 5: Essentially independent of operating temperature

特性曲线 Typical Characteristics



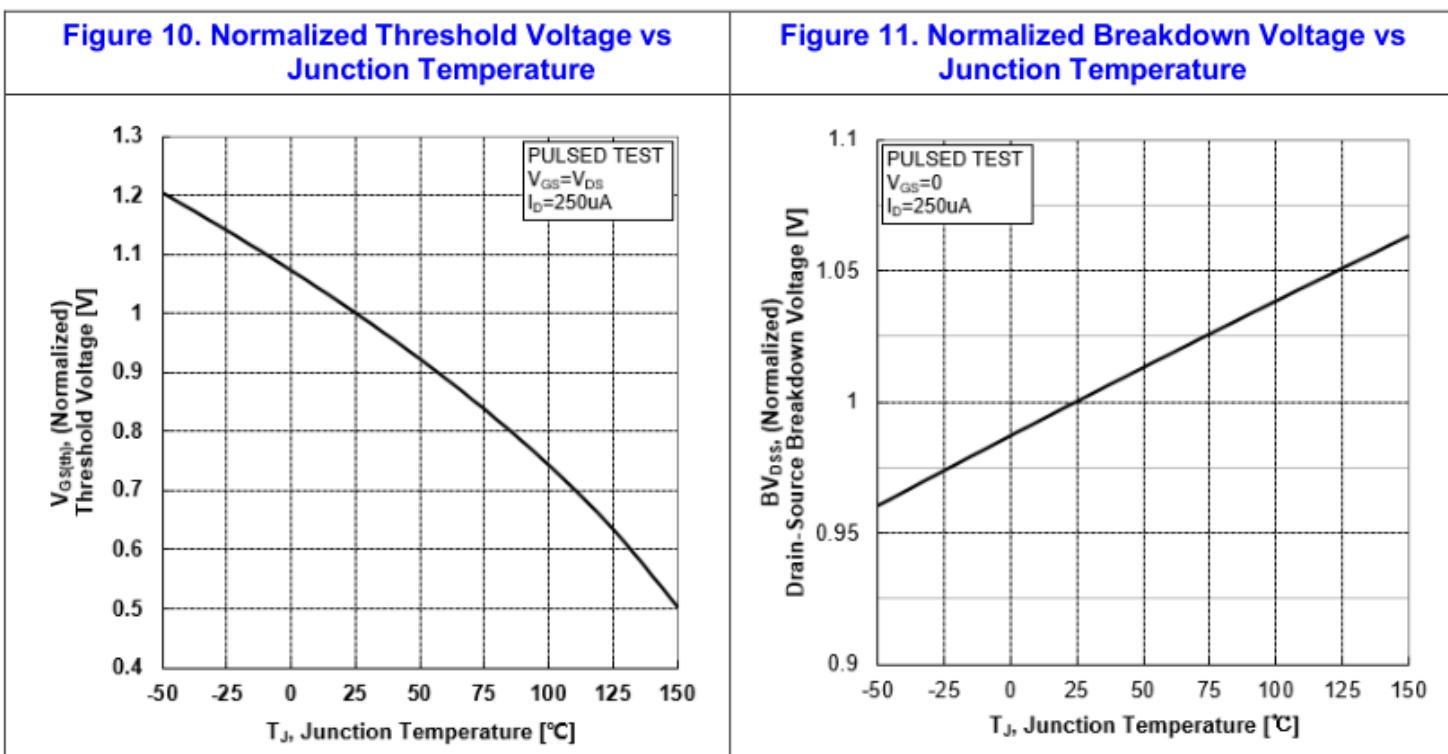
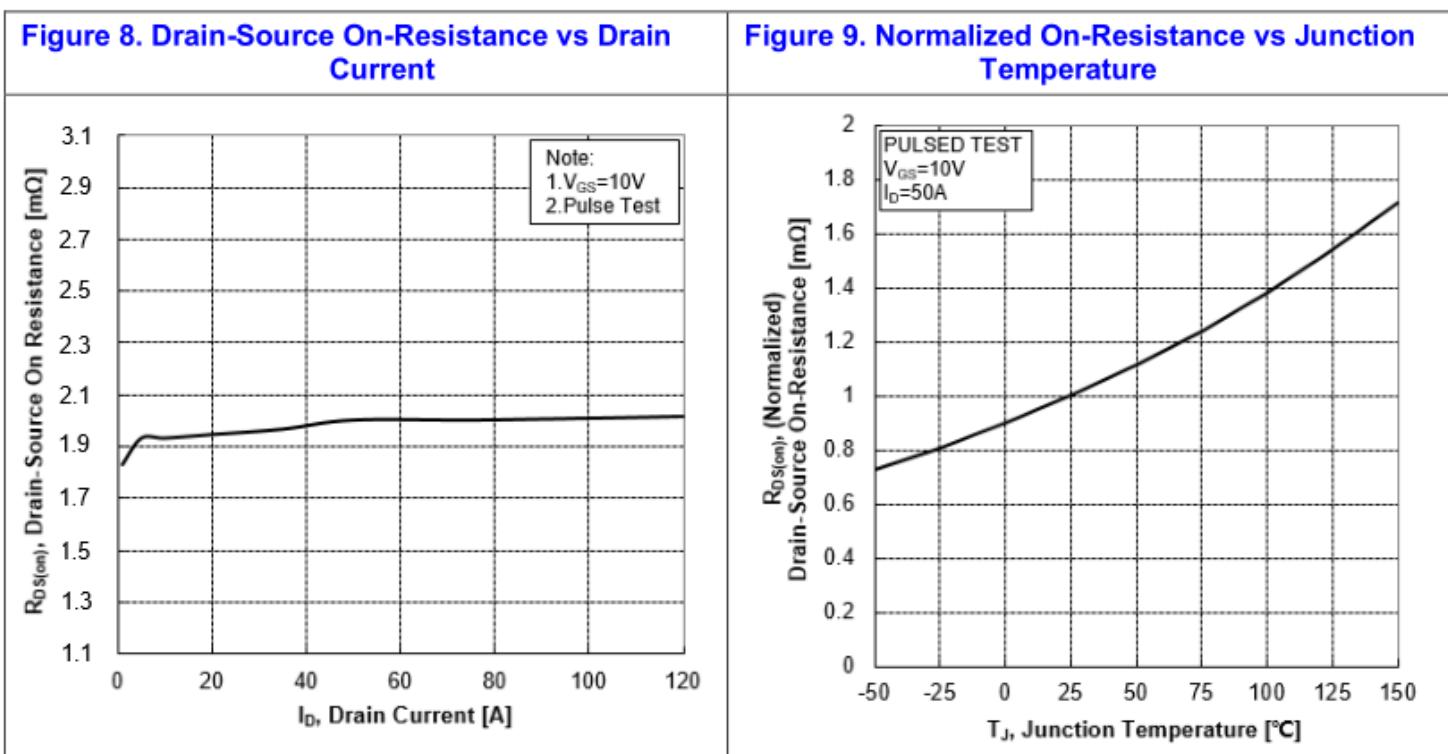
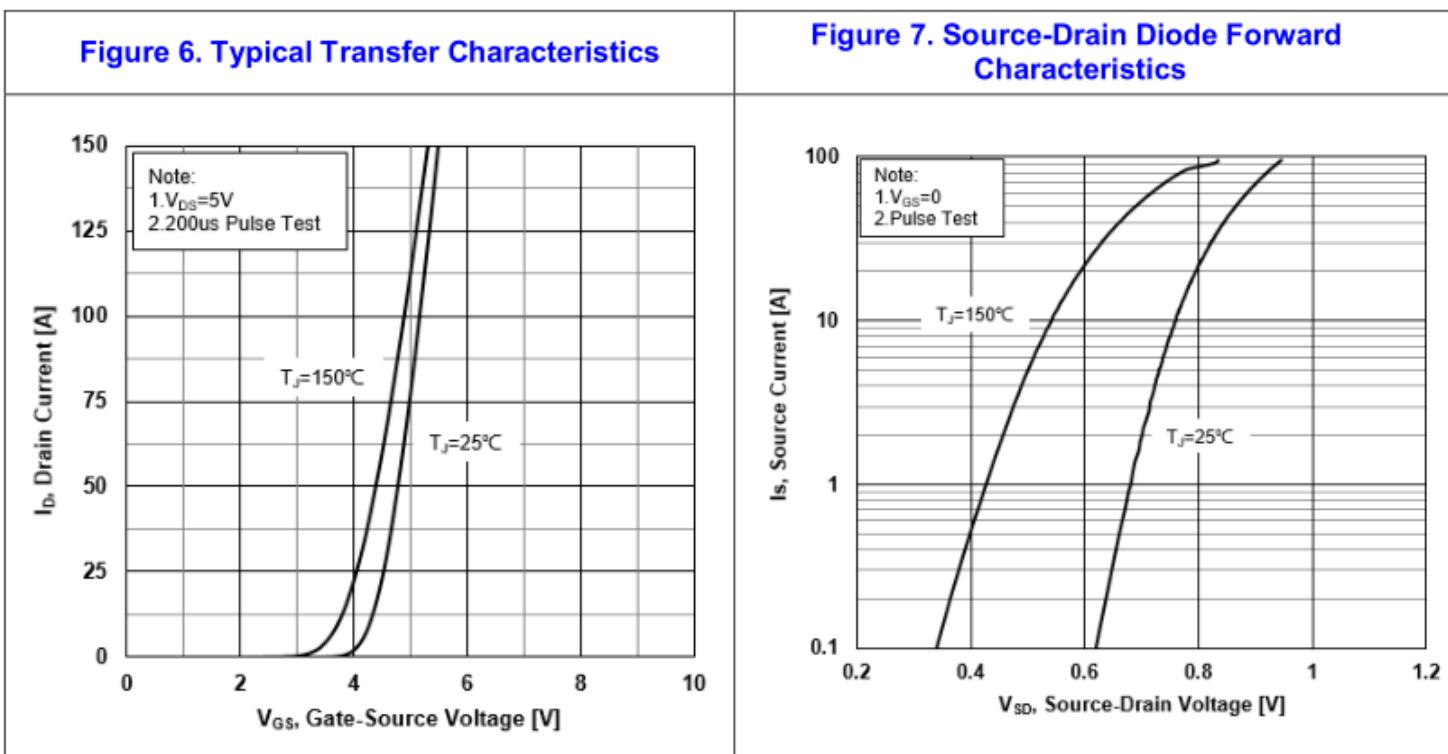


Figure 12. Capacitance Characteristics

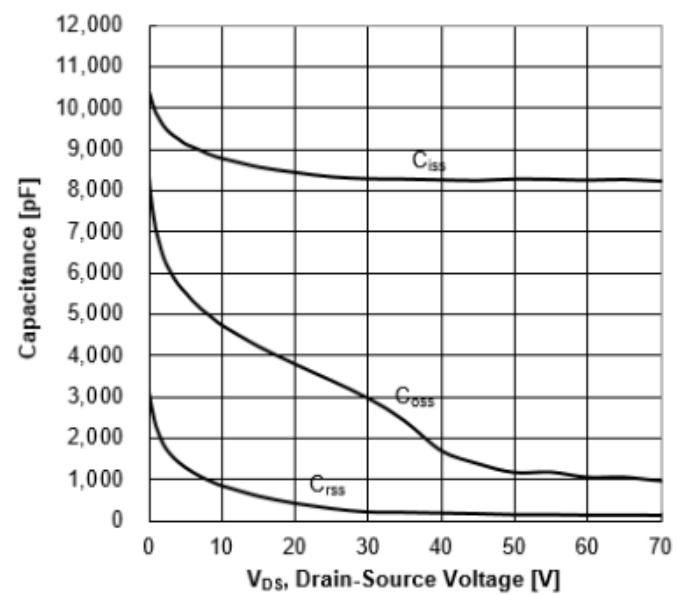
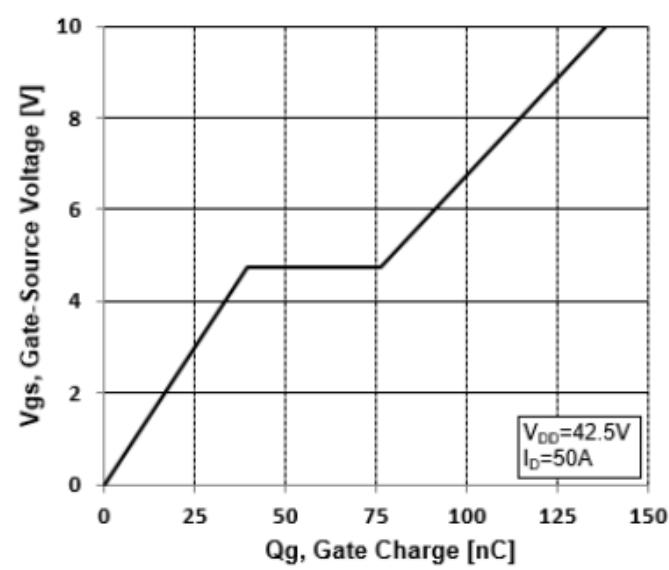
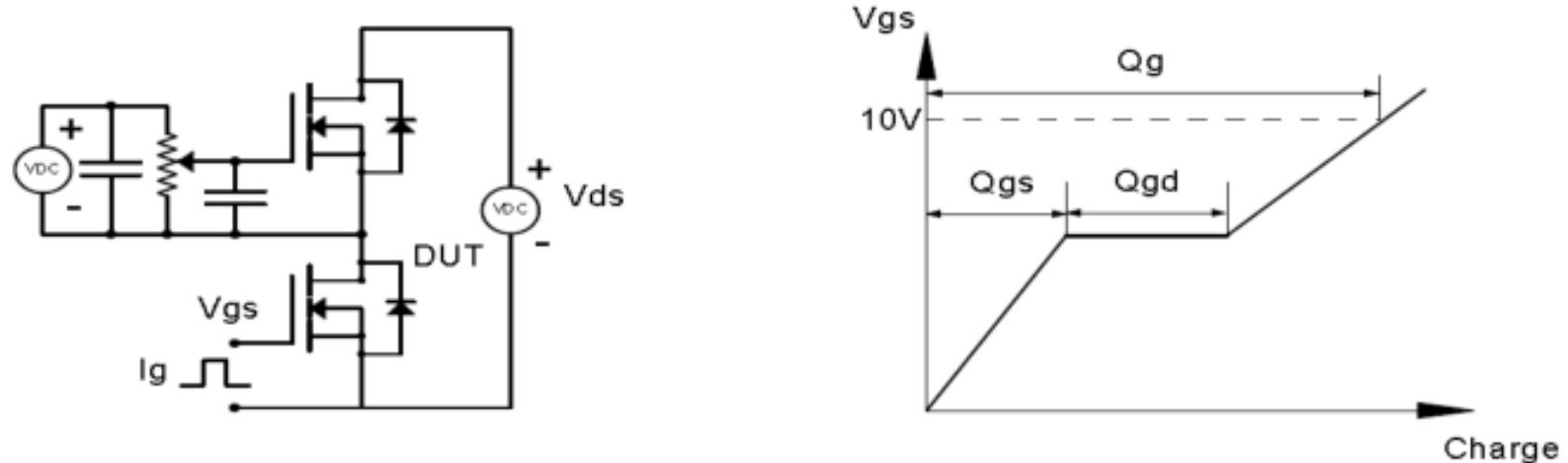


Figure 13. Typical Gate Charge vs Gate-Source Voltage

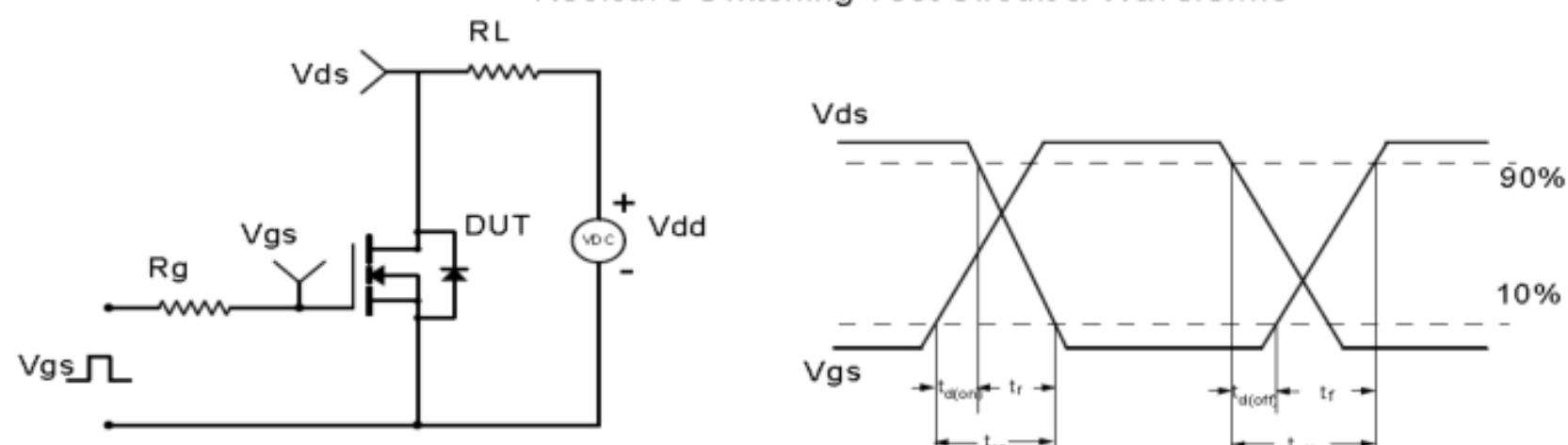


Test Circuit & Waveform

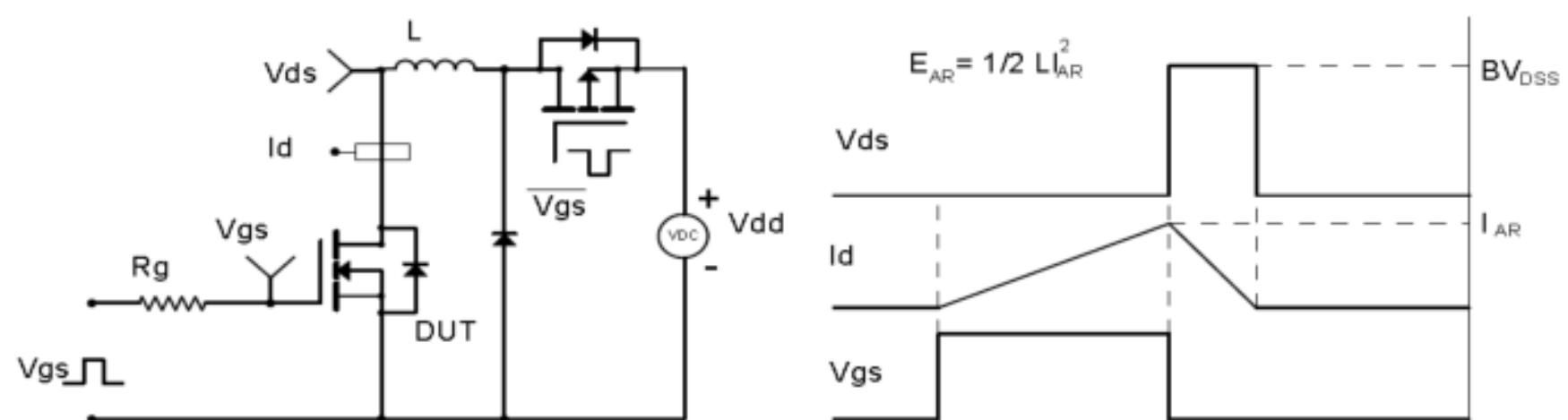
Gate Charge Test Circuit & Waveform



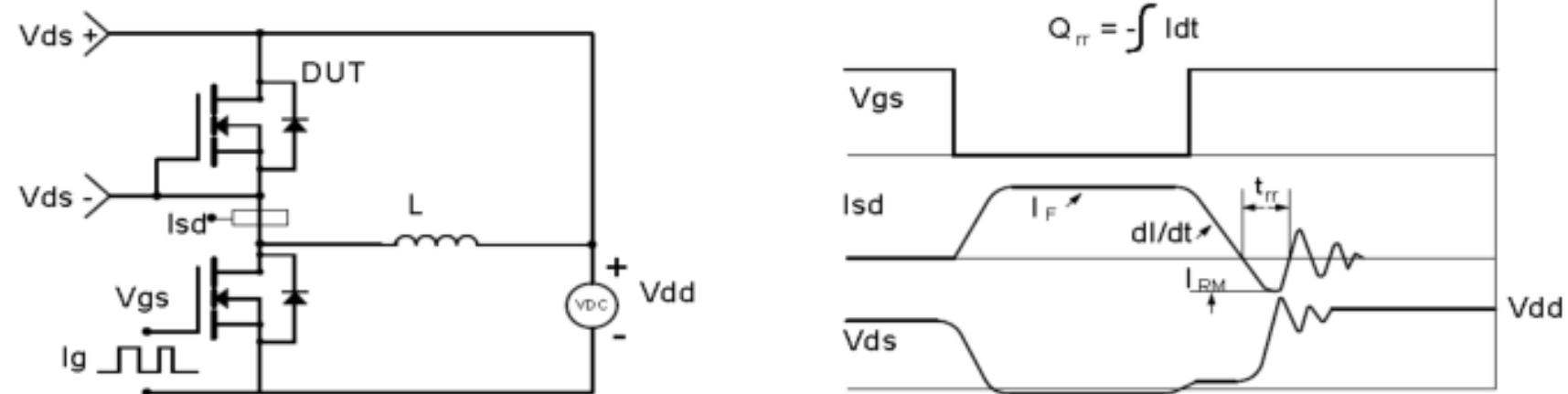
Resistive Switching Test Circuit & Waveforms



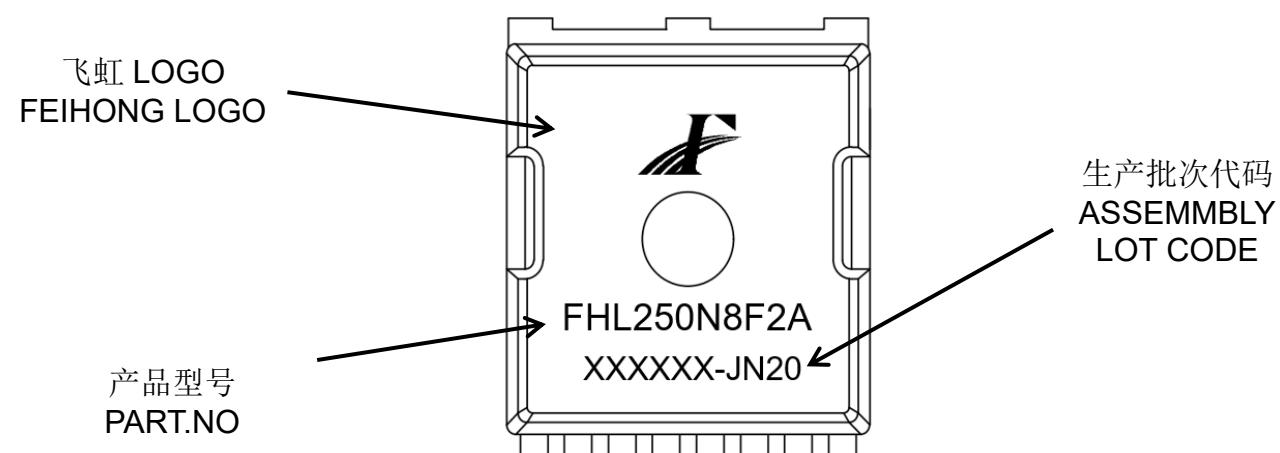
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



印记 Marking:



外形尺寸:

Package Dimension:

TOLL8

